Notice of References Cited Application/Control No. 10/811,881 Applicant(s)/Patent Under Reexamination NAKABAYSHI ET AL. Examiner Thomas D. Lee 2625 Applicant(s)/Patent Under Reexamination NAKABAYSHI ET AL.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,335,097	08-1994	Murakami, Shigeo	358/520
*	В	US-5,587,799	12-1996	Kawamura et al.	358/296
*	С	US-7,184,171	02-2007	Hara, Kenji	358/1.9
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-	·		
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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